

Notice of References Cited	Application/Control No. 10/502,088	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Mark T. Vogelbacker	Art Unit 3677	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0052167 A1	12-2001	Cho, Gyu Yeol	16/337
	B	US-5,682,645	11-1997	Watabe et al.	16/338
	C	US-6,584,646 B2	07-2003	Fujita, Oriya	16/342
	D	US-5,598,607	02-1997	Katagiri, Takashi	16/337
	E	US-6,754,081 B2	06-2004	Rude et al.	361/725
	F	US-6,085,388	07-2000	Kaneko, Takayuki	16/338
	G	US-5,500,982	03-1996	Hosoi, Takashi	16/297
	H	US-6,698,063 B2	03-2004	Kim et al.	16/337
	I	US-5,467,504	11-1995	Yang, A-Tso	16/342
	J	US-5,092,017	03-1992	Hatano et al.	16/277
	K	US-5,542,152	08-1996	Crompton et al.	16/354
	L	US-5,022,778	06-1991	Lu, Sheng N.	403/120
	M	US-5,894,633	04-1999	Kaneko, Takayuki	16/306

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003248527 A	09-2003	Japan	KATAGIRI, TAKASHI	G06F 01/16
	O	JP 2001329735 A	11-2001	Japan	SASAKI et al.	E05D 11/08
	P	JP 2000257324 A	09-2000	Japan	SAITO, KAZUO	E05D 11/08
	Q	JP 11085038 A	03-1999	Japan	OGURA, KAZUMASA	E05D 11/08
	R	JP 11247840 A	09-1999	Japan	HIGANO et al.	F16C 11/10
	S	JP 2000130461 A	05-2000	Japan	ICHINOHE et al.	F16D 13/08
	T	JP 03176582 A	07-1991	Japan	KINOSHITA, KOZO	E05D 11/06

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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